

### Subject Description Form

<b>Subject Code</b>	EIE2102 (for 42470 and 42375)
<b>Subject Title</b>	Basic Electronics
<b>Credit Value</b>	3
<b>Level</b>	2
<b>Pre-requisite</b>	<p><u>For 42470:</u> EIE2100 Basic Circuit Analysis</p> <p><u>For 42375:</u> EIE2101 Basic Circuit Analysis /EIE2110 Basic Circuit Analysis and Electronics</p>
<b>Co-requisite/ Exclusion</b>	Nil
<b>Objectives</b>	To introduce the operating principles of electronic circuits. Several classes of electronic circuits will be covered in this subject – diode circuits, BJT transistor circuits, FET transistor circuits. An introduction to power amplifiers will also be given.
<b>Intended Subject Learning Outcomes</b>	<p><b>Upon completion of the subject, students will be able to:</b></p> <p><u>Category A: Professional/academic knowledge and skills</u></p> <ol style="list-style-type: none"> <li>1. Acquire some understanding in the fundamental electric and electronics principles.</li> <li>2. Solve basic problems in electric and electronic circuits.</li> <li>3. Acquire better skills in performing the laboratory experiments.</li> </ol> <p><u>Category B: Attributes for all-roundedness</u></p> <ol style="list-style-type: none"> <li>4. Perform independent learning in basic electric and electronic principles.</li> <li>5. Work as a team in laboratory sessions.</li> </ol>
<b>Subject Synopsis/ Indicative Syllabus</b>	<p><b>Syllabus:</b></p> <ol style="list-style-type: none"> <li>1. <u>Load Line Analysis and Diode Circuits</u> I-V characteristics of diodes and general nonlinear components. DC solution based on load line construction. Practical diode circuits: rectifier circuits, clipping and clamping circuits.</li> <li>2. <u>Transistors and Biasing Circuits</u> The bipolar junction transistors (BJT). DC biasing and analysis of BJT circuits. Metal-oxide-semiconductor field-effect transistor (MOSFET). DC biasing and analysis of MOSFET circuits. Load line and graphical large-signal analysis. Transistor amplification concept.</li> <li>3. <u>Transistor Amplifiers and Small-signal Concepts</u> Basic BJT and MOSFET amplifier configurations: common emitter and common source configurations. Small-signal models and parameters with reference to two-port networks. Concept of transconductance. Voltage gain. Input and output impedances. Introduction to loading effect.</li> <li>4. <u>Introduction to Frequency Domain Analysis</u> Transfer functions from ac circuits in terms of <math>j\omega</math>. Introduction to frequency domain, from <math>j\omega</math> to <math>s</math>. General <math>s</math>-domain transfer functions. Simple first-order filter circuits. Introducing concepts of pole, corner frequency, bandwidth. For sinusoidal driving sources, use of <math>j\omega</math> axis for magnitude and phase plots. Extension to asymptotic plots and hence Bode plots.</li> </ol>

5. Fundamentals of Power Amplifiers  
 Concept of conversion efficiency. Class A, Class B & Class AB operations of power amplifiers and the related circuits.

**Laboratory Experiments:**

1. DC transistor biasing/load line and diode clamping circuits.
2. Transistor amplifier circuits.
3. Design of a simple transistor amplifier.
4. OCL class AB power amplifier.

<b>Teaching/ Learning Methodology</b>	<b>Teaching and Learning Method</b>	<b>Intended Subject Learning Outcome</b>	<b>Remarks</b>
	Lectures, supplemented with interactive questions and answers	1, 2, 4	In lectures, students are introduced to the <i>knowledge</i> of the subject, and <i>comprehension</i> is strengthened with interactive Q&A.
	Tutorials, where problems are discussed and are given to students for them to solve	1, 2, 4	In tutorials, students <i>apply</i> what they have learnt in solving the problems given by the tutor.
	Laboratory sessions, where students will perform experimental verifications. They will have to record results and write a report on one of the experiments.	2, 3, 5	Students <i>acquire</i> hands-on experience in using electronic equipment and <i>apply</i> what they have learnt in lectures/tutorials to experimentally validate the theoretical investigations.

<b>Assessment Methods in Alignment with Intended Learning Outcomes</b>	<b>Specific Assessment Methods/ Task</b>	<b>% Weighting</b>	<b>Intended Subject Learning Outcomes to be Assessed (Please tick as appropriate)</b>				
			<b>1</b>	<b>2</b>	<b>3</b>	<b>4</b>	<b>5</b>
	1. Continuous Assessment		✓	✓	✓	✓	✓
	Mid-semester test	12%					
	End-of-semester test	12%					
Lab	16%						
2. Examination	60%	✓	✓		✓		
<b>Total</b>	<b>100%</b>						

	<p><b>Explanation of the appropriateness of the assessment methods in assessing the intended learning outcomes:</b></p> <table border="1"> <thead> <tr> <th>Specific Assessment Methods/Tasks</th> <th>Remark</th> </tr> </thead> <tbody> <tr> <td>Laboratory works and reports</td> <td>Students will be required to perform two experiments and submit a report on one of the experiments.</td> </tr> <tr> <td>Mid-semester test</td> <td>There will be a mid-semester test to evaluate students' achievement of all the learning outcomes and give feedback to them for prompt improvement.</td> </tr> <tr> <td>End-of-semester test and Examination</td> <td>There will be an end-of-semester test and examination to assess students' achievement of all the learning outcomes. These are mainly summative in nature.</td> </tr> </tbody> </table>		Specific Assessment Methods/Tasks	Remark	Laboratory works and reports	Students will be required to perform two experiments and submit a report on one of the experiments.	Mid-semester test	There will be a mid-semester test to evaluate students' achievement of all the learning outcomes and give feedback to them for prompt improvement.	End-of-semester test and Examination	There will be an end-of-semester test and examination to assess students' achievement of all the learning outcomes. These are mainly summative in nature.
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<b>Student Study Effort Expected</b>	<b>Class contact (time-tabled):</b>									
	• Lecture	24 Hours								
	• Tutorial/Laboratory/Practice Classes	15 hours								
	<b>Other student study effort:</b>									
	• Lecture: preview/review of notes; preparation for test/quizzes/examination	36 Hours								
	• Tutorial/Laboratory/Practice Classes: preview of materials, revision and/or reports writing	30 Hours								
	<b>Total student study effort:</b>	<b>105 Hours</b>								
<b>Reading List and References</b>	<p><b>Textbook:</b>  1. G. Rizzoni, <i>Fundamentals of Electrical Engineering</i>, 1<sup>st</sup> ed., McGraw-Hill, 2009.</p> <p><b>References:</b>  1. D.A. Neamen, <i>Micoelectronics:Circuit Analysis and Design</i>, Boston: McGraw-Hill, 3<sup>rd</sup> ed., 2007.  2. A.H. Robbins and W.C. Miller, <i>Circuit Analysis: Theory and Practice</i>, Thomson Learning, 4<sup>th</sup> ed., 2006.</p>									
<b>Last Updated</b>	June 2021									
<b>Prepared by</b>	Dr W. Y. Tam									